

10/523,536

FOREIGN PATENT OR PUBLISHED FOREIGN APPLICATION						
		DOCUMENT NUMBER	PUB. DATE	COUNTRY		TRANSLATION
/R.B./	BA	WD 9935185	7/15/99	WIPO		English
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/R.B./	CA	U.S. Patent Application 10/523,502, by Michel et al., filed 2/2/2005.
	CB	International Search Report for PCT/EP 03/07423, mailed 10/28/2003.
	CC	English Translation of IPER for PCT/EP 03/07423, mailed 5/7/2005
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/R.B./	CE	English Abstract for JP Publication NO. 10-090941, 4/10/1998
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EXAMINER /Rachel Burney/		DATE CONSIDERED 08/02/2007
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